

SIPMOS® Small-Signal-Transistor

Product Summary

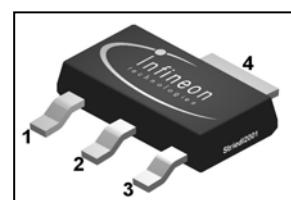
Features

- P-Channel
- Enhancement mode
- Logic level
- Avalanche rated
- dv/dt rated
- Pb-free lead plating; RoHS compliant
- Qualified according to AEC Q101
- Halogen-free according to IEC61249-2-21

V_{DS}	-60	V
$R_{DS(on),max}$	0.3	Ω
I_D	-1.9	A



PG-SOT223



Type	Package	Tape and Reel Information	Marking	Packaging
BSP171P	PG-SOT223	H6327: 1000 pcs/reel	BSP171P	Non dry

Maximum ratings, at $T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
			steady state	
Continuous drain current	I_D	$T_A=25^\circ\text{C}^1)$	-1.9	A
		$T_A=70^\circ\text{C}^1)$	-1.5	
Pulsed drain current	$I_{D,pulse}$	$T_A=25^\circ\text{C}$	-7.6	
Avalanche energy, single pulse	E_{AS}	$I_D=-1.9\text{ A}$, $R_{GS}=25\Omega$	70	mJ
Reverse diode dv/dt	dv/dt	$I_D=-1.9\text{ A}$, $V_{DS}=-48\text{ V}$, $di/dt=-200\text{ A}/\mu\text{s}$, $T_{j,max}=150^\circ\text{C}$	-6	kV/ μs
Gate source voltage	V_{GS}		± 20	V
Power dissipation	P_{tot}	$T_A=25^\circ\text{C}^1)$	1.8	W
Operating and storage temperature	T_j , T_{stg}		-55 ... 150	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1			55/150/56	

ESD Class; JESD22-A114-HBM

Class 1a

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - soldering point	R_{thJS}		-	-	25	K/W
Thermal resistance, junction - ambient	R_{thJA}	minimal footprint, steady state	-	-	110	
		6 cm ² cooling area ¹⁾ , steady state	-	-	70	

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0$ V, $I_D=-250$ µA	-60	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=-460$ µA	-1	-1.5	-2	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=-60$ V, $V_{GS}=0$ V, $T_j=25$ °C	-	-0.1	-1	µA
		$V_{DS}=-60$ V, $V_{GS}=0$ V, $T_j=125$ °C	-	-10	-100	
Gate-source leakage current	I_{GSS}	$V_{GS}=-20$ V, $V_{DS}=0$ V	-	-10	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=-4.5$ V, $I_D=-1.5$ A	-	0.3	0.45	Ω
		$V_{GS}=-10$ V, $I_D=-1.9$ A	-	0.21	0.3	
Transconductance	g_{fs}	$ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=-1.5$ A	1.4	2.7	-	S

¹⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}$, $V_{DS}=-25\text{ V}$, $f=1\text{ MHz}$	-	365	460	pF
Output capacitance	C_{oss}		-	105	135	
Reverse transfer capacitance	C_{rss}		-	40	55	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=-25\text{ V}$, $V_{GS}=-10\text{ V}$, $I_D=1.9\text{ A}$, $R_G=6\Omega$	-	6	8	ns
Rise time	t_r		-	25	33	
Turn-off delay time	$t_{d(off)}$		-	208	276	
Fall time	t_f		-	87	130	

Gate Charge Characteristics²⁾

Gate to source charge	Q_{gs}	$V_{DD}=-48\text{ V}$, $I_D=1.9\text{ A}$, $V_{GS}=0$ to -10 V	-	-1.2	-1.6	nC
Gate to drain charge	Q_{gd}		-	-5	-7	
Gate charge total	Q_g		-	-13	-20	
Gate plateau voltage	$V_{plateau}$		-	-3	-	V
Output charge	Q_{oss}	$V_{DD}=-15\text{ V}$, $V_{GS}=0\text{ V}$	-	-5	-7	

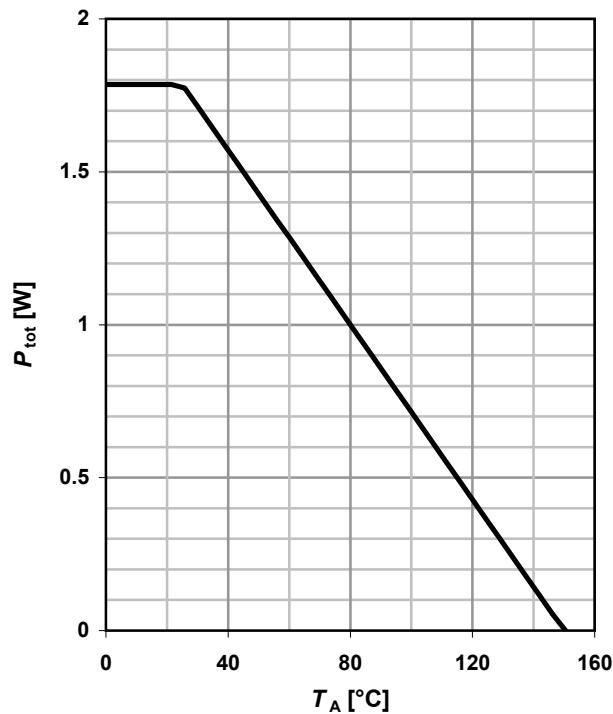
Reverse Diode

Diode continuous forward current	I_S	$T_A=25\text{ }^\circ\text{C}$	-	-	-1.9	A
Diode pulse current	$I_{S,pulse}$		-	-	-7.6	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}$, $I_F=1.9\text{ A}$, $T_j=25\text{ }^\circ\text{C}$	-	-0.84	-1.1	V
Reverse recovery time	t_{rr}	$V_R=-30\text{ V}$, $I_F= I_S $, $di_F/dt=100\text{ A}/\mu\text{s}$	-	80	120	ns
Reverse recovery charge	Q_{rr}		-	-125	-190	nC

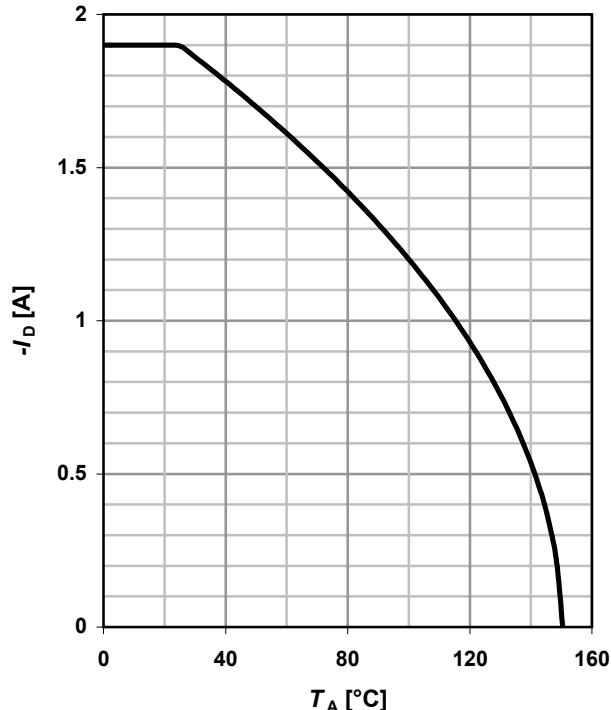
²⁾ See figure 16 for gate charge parameter definition

1 Power dissipation

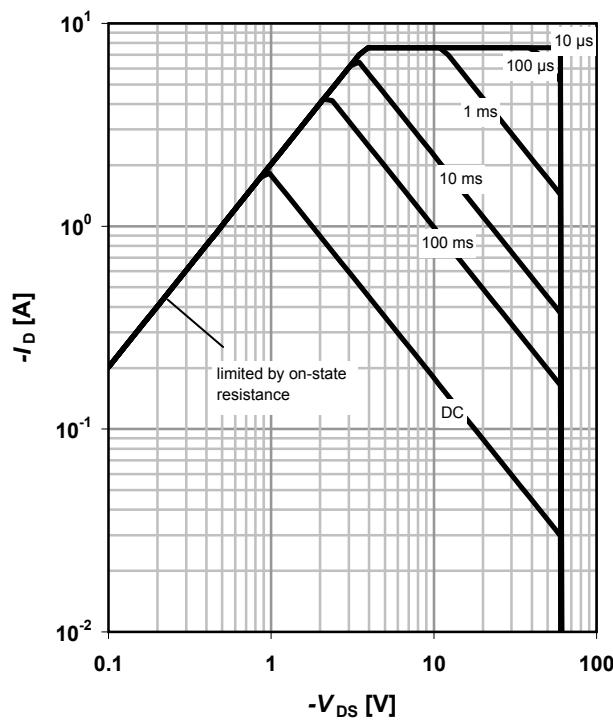
$$P_{\text{tot}} = f(T_A)$$


2 Drain current

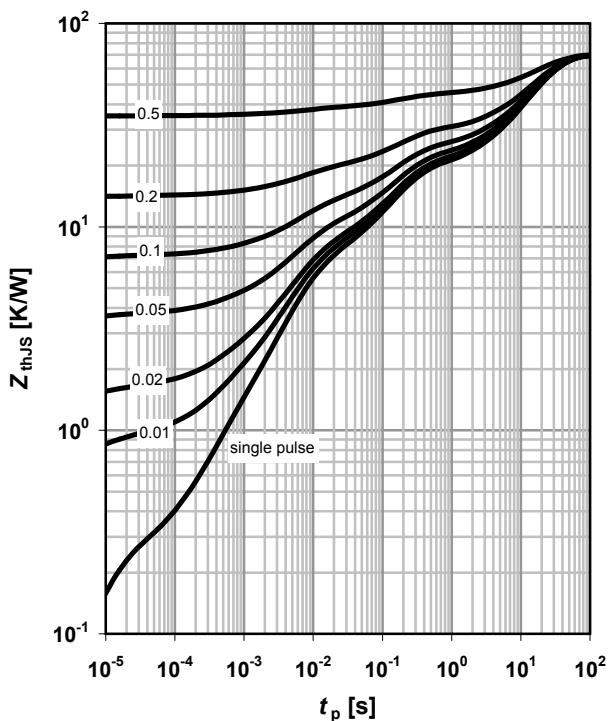
$$I_D = f(T_A); |V_{GS}| \geq 10 \text{ V}$$


3 Safe operating area

$$I_D = f(V_{DS}); T_A = 25 \text{ °C}^1; D = 0$$

parameter: t_p

4 Max. transient thermal impedance

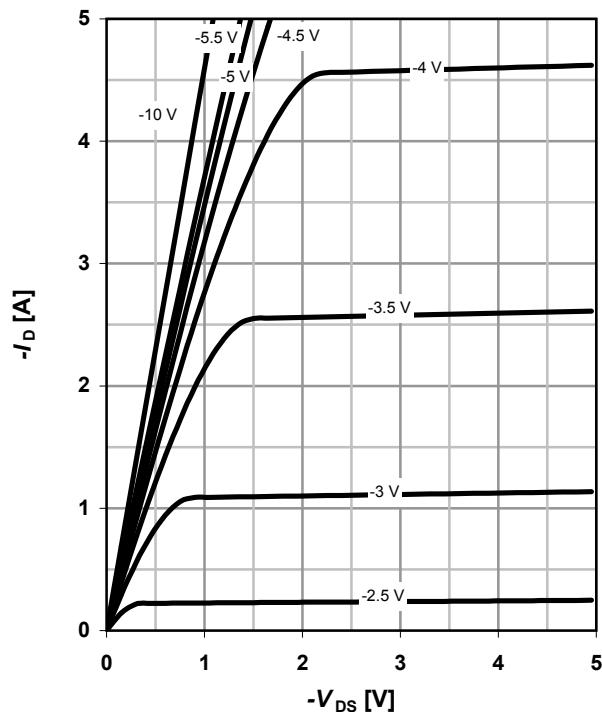
$$Z_{\text{thJA}} = f(t_p)$$

parameter: $D = t_p/T$


5 Typ. output characteristics

$I_D=f(V_{DS})$; $T_j=25\text{ }^\circ\text{C}$

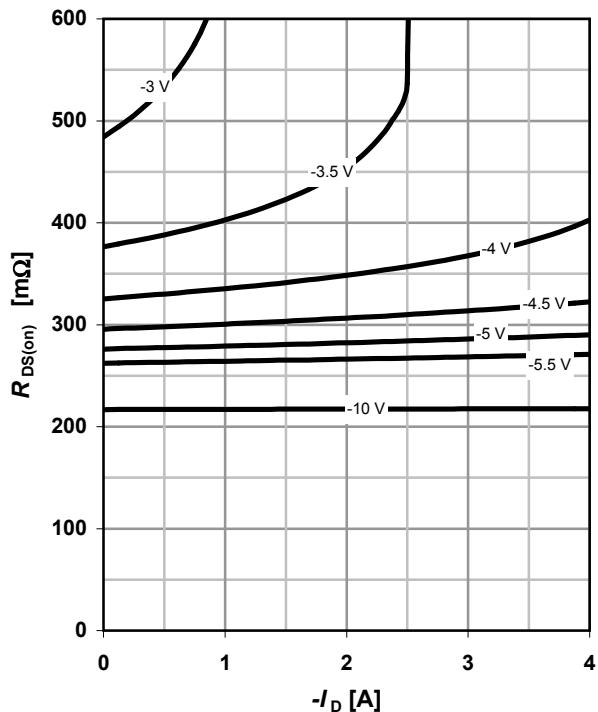
parameter: V_{GS}



6 Typ. drain-source on resistance

$R_{DS(on)}=f(I_D)$; $T_j=25\text{ }^\circ\text{C}$

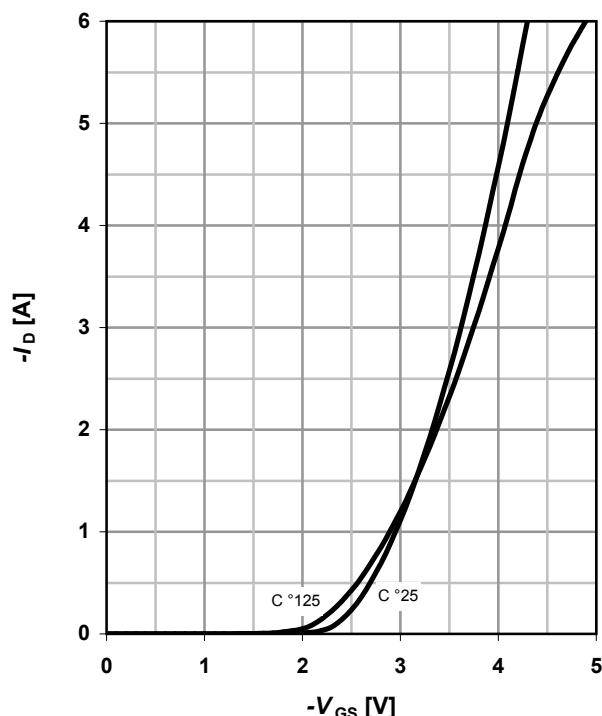
parameter: V_{GS}



7 Typ. transfer characteristics

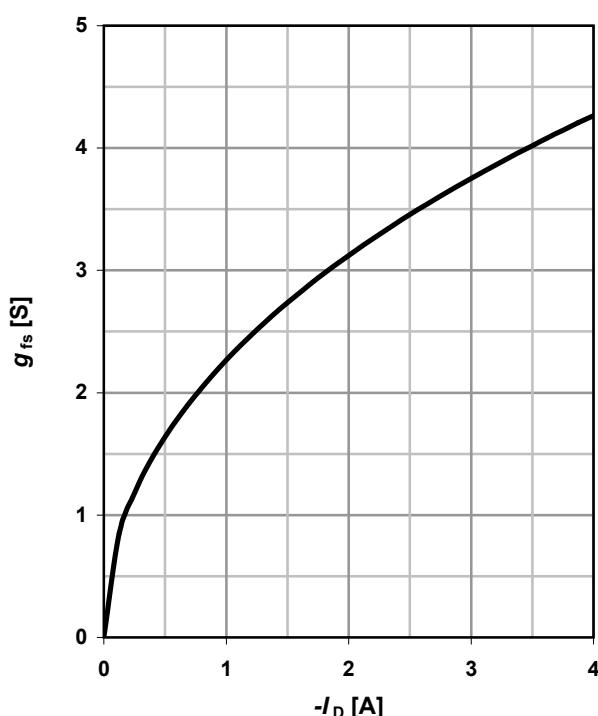
$I_D=f(V_{GS})$; $|V_{DS}|>2|I_D|R_{DS(on)max}$

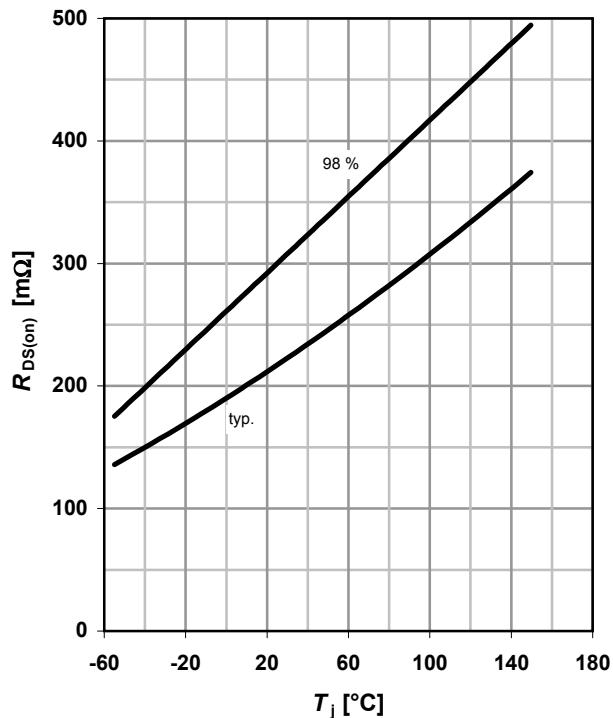
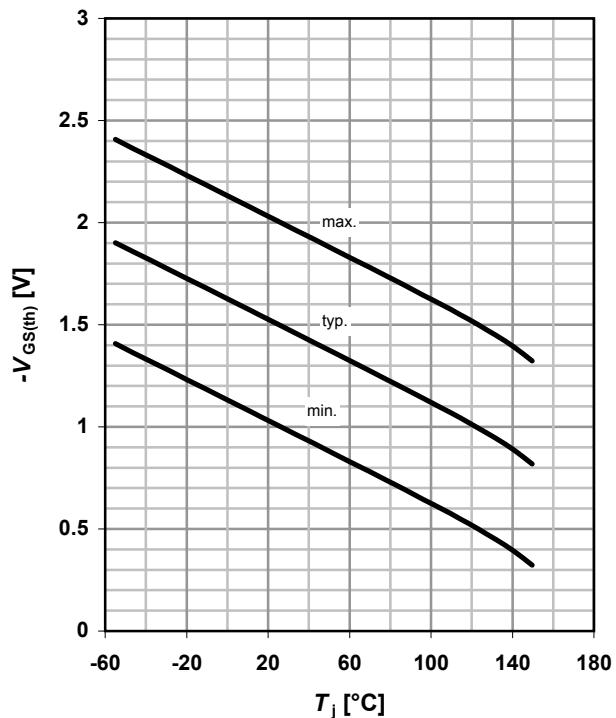
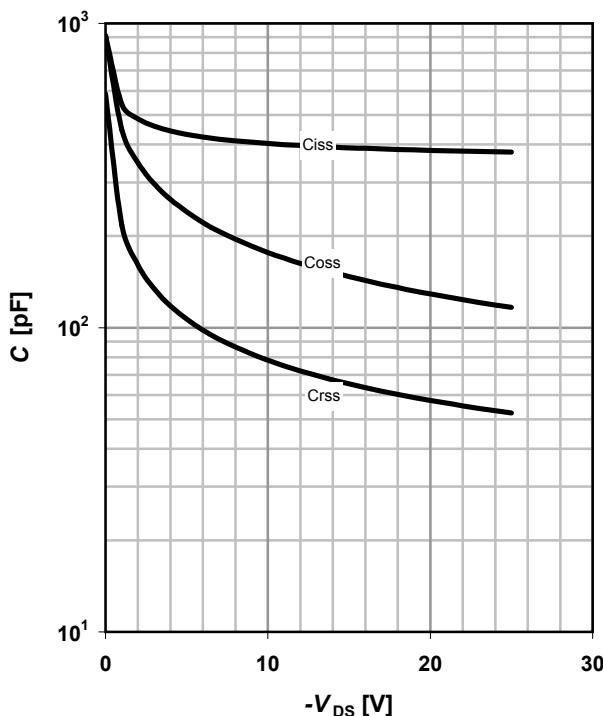
parameter: T_j

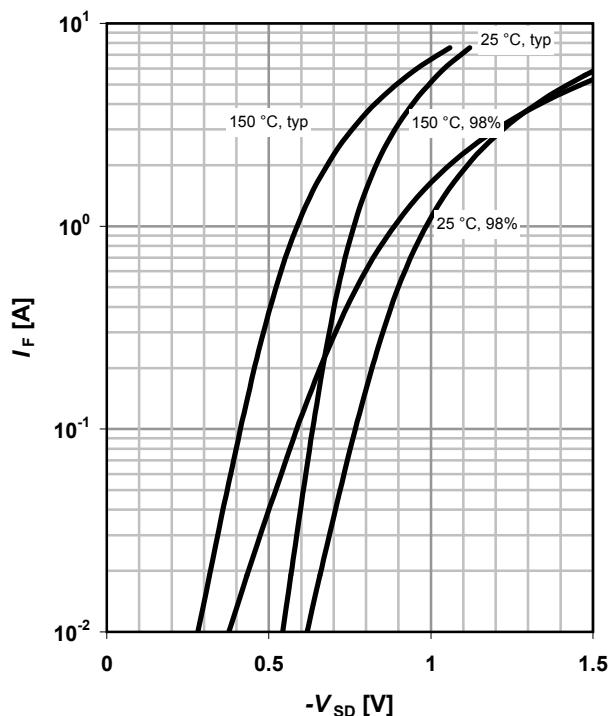


8 Typ. forward transconductance

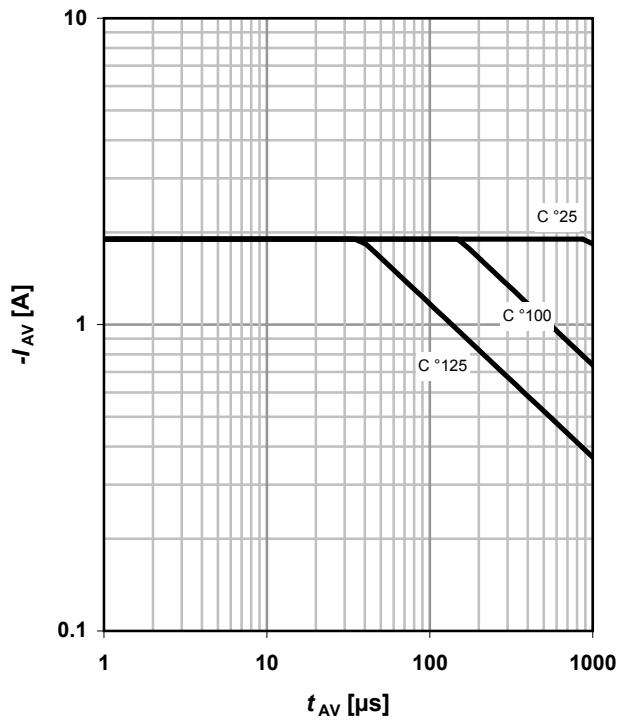
$g_{fs}=f(I_D)$; $T_j=25\text{ }^\circ\text{C}$

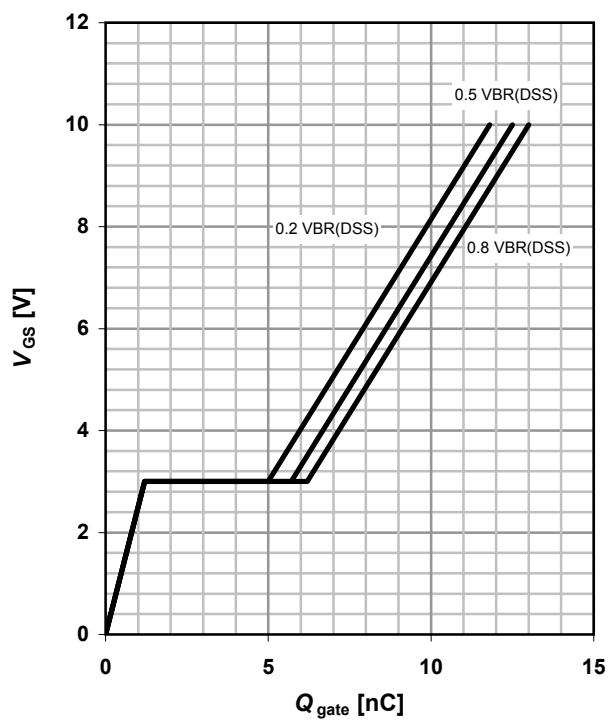
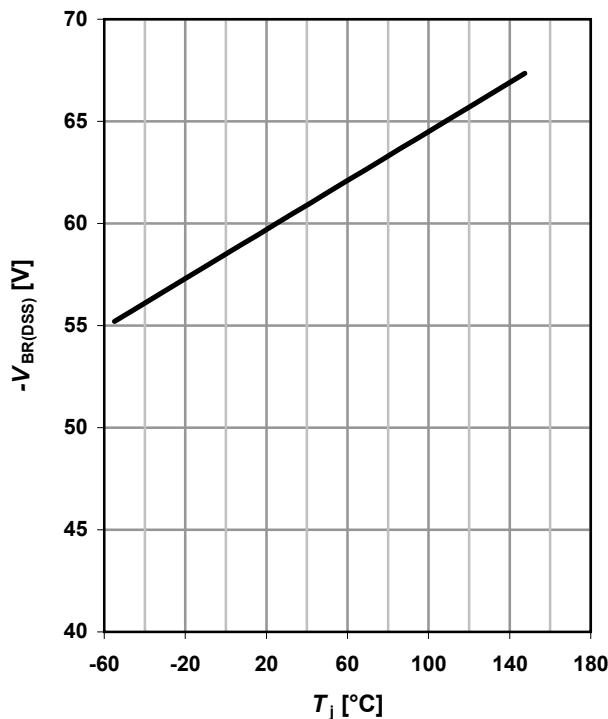
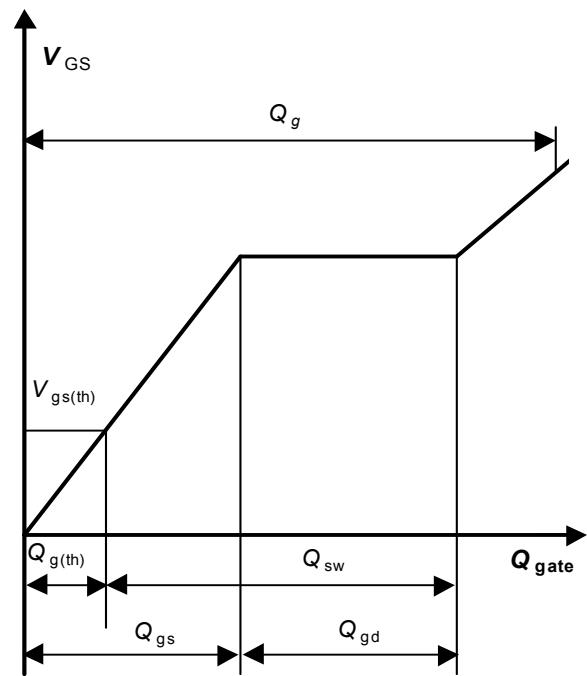


9 Drain-source on-state resistance
 $R_{DS(on)} = f(T_j); I_D = -1.9 \text{ A}; V_{GS} = -10 \text{ V}$

10 Typ. gate threshold voltage
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; I_D = -460 \mu\text{A}$

11 Typ. capacitances
 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

12 Forward characteristics of reverse diode
 $I_F = f(V_{SD})$

 parameter: T_j


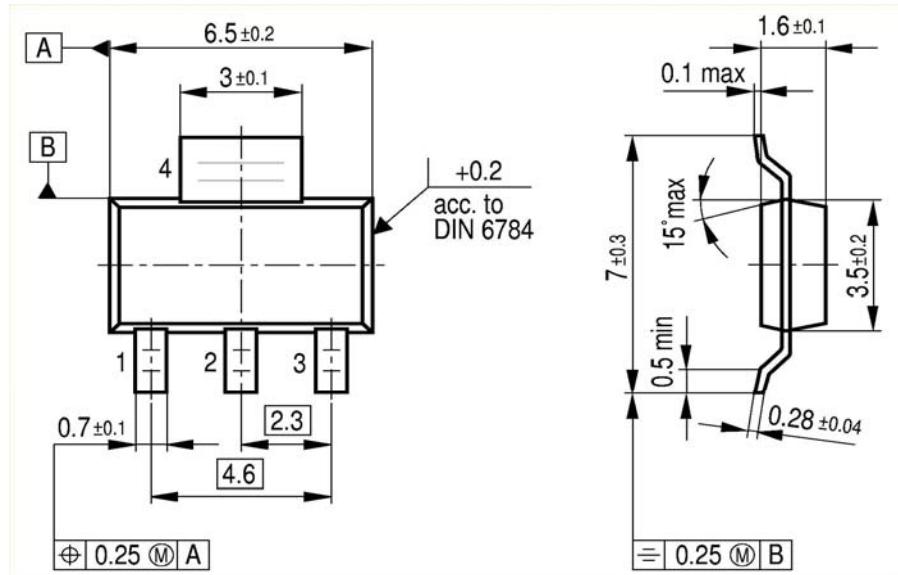
13 Avalanche characteristics
 $I_{AV} = f(t_{AV})$; $R_{GS} = 25 \Omega$

parameter: $T_j(\text{start})$

14 Typ. gate charge
 $V_{GS} = f(Q_{gate})$; $I_D = -1.9 \text{ A pulsed}$

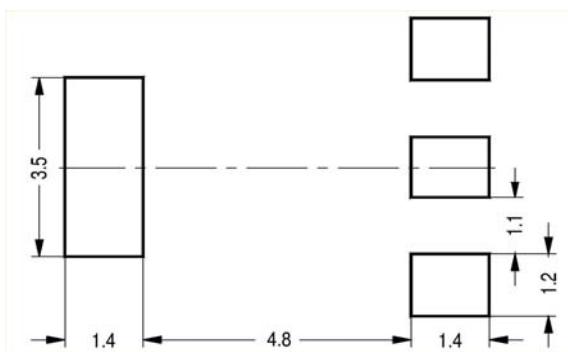
parameter: V_{DD}

15 Drain-source breakdown voltage
 $-V_{BR(DSS)} = f(T_j)$; $I_D = -1 \text{ mA}$

16 Gate charge waveforms


Package Outline

SOT-223: Outline

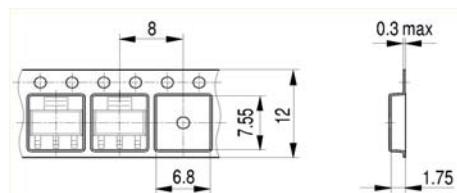


Footprint



Packaging

Tape



Dimensions in mm



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Infineon Technologies AG
81726 Munich, Germany
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